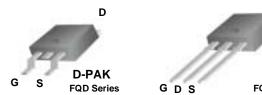
### FAIRCHILD January 2009 SEMICONDUCTOR OFE FQD20N06 / FQU20N06 **60V N-Channel MOSFET General Description** Features 16.8A, 60V, R<sub>DS(on)</sub> = 0.063Ω @ V<sub>GS</sub> = 10V Low gate charge ( typical 11.5 nC) These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology. • Low Crss (typical 25 pF) This advanced technology has been especially tailored to Fast switching minimize on-state resistance, provide superior switching • 100% avalanche tested performance, and withstand high energy pulse in the Improved dv/dt capability avalanche and commutation mode. These devices are well 150°C maximum junction temperature rating suited for low voltage applications such as automotive, DC/ RoHS Compliant DC converters, and high efficiency switching for power management in portable and battery operated products. D



I-PAK FQU Series



FQD20N06 / FQU20N06

## Absolute Maximum Ratings T<sub>c</sub> = 25°C unless otherwise noted

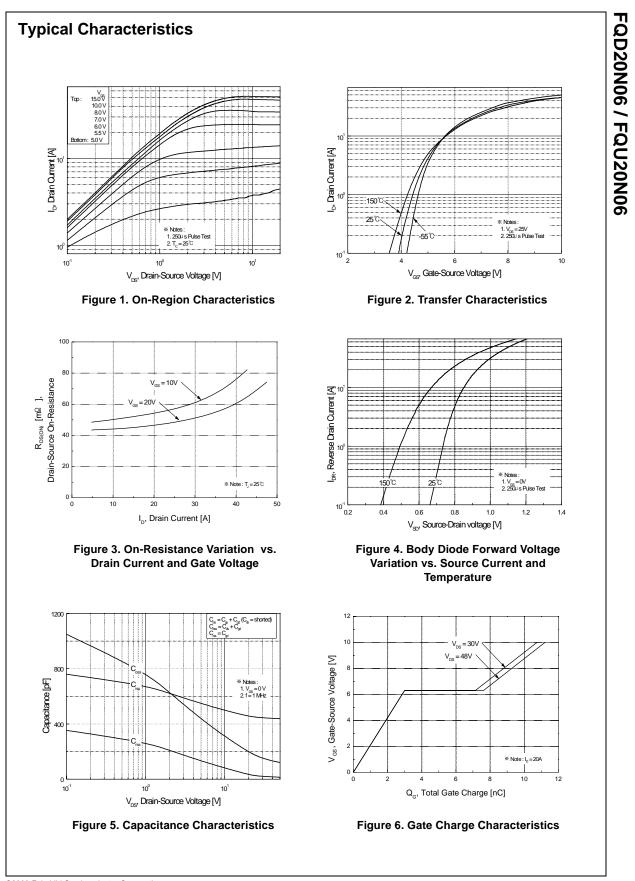
Symbol	Parameter		FQD20N06 / FQU20N06	Units
V <sub>DSS</sub>	Drain-Source Voltage		60	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°	°C)	16.8	А
	- Continuous (T <sub>C</sub> = 10	O°C)	10.6	А
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	67.2	А
V <sub>GSS</sub>	Gate-Source Voltage		± 25	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)		155	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	16.8	А
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	3.8	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	7.0	V/ns
P <sub>D</sub>	Power Dissipation ( $T_A = 25^{\circ}C$ ) *		2.5	W
	Power Dissipation ( $T_C = 25^{\circ}C$ )		38	W
	- Derate above 25°C		0.30	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
Τ <sub>L</sub>	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

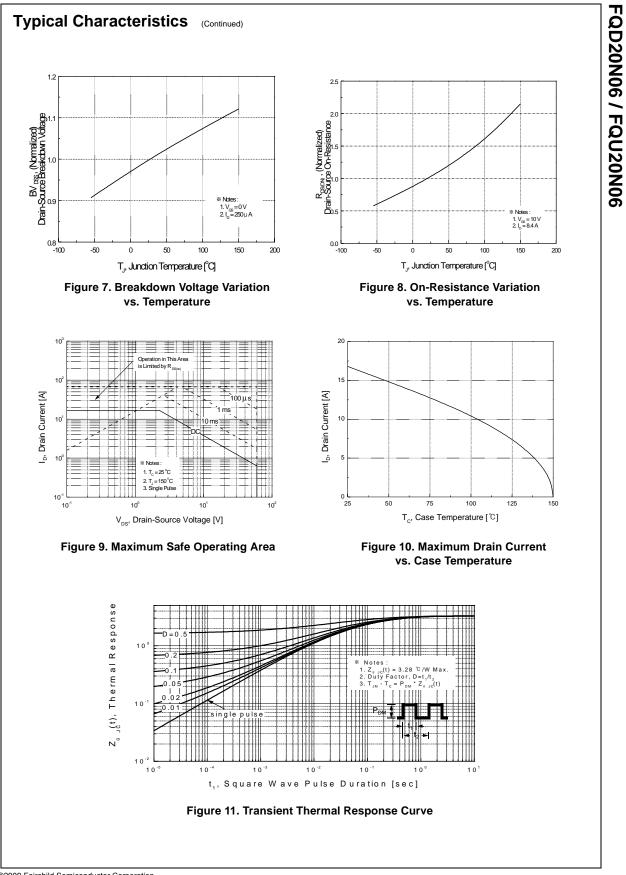
# **Thermal Characteristics**

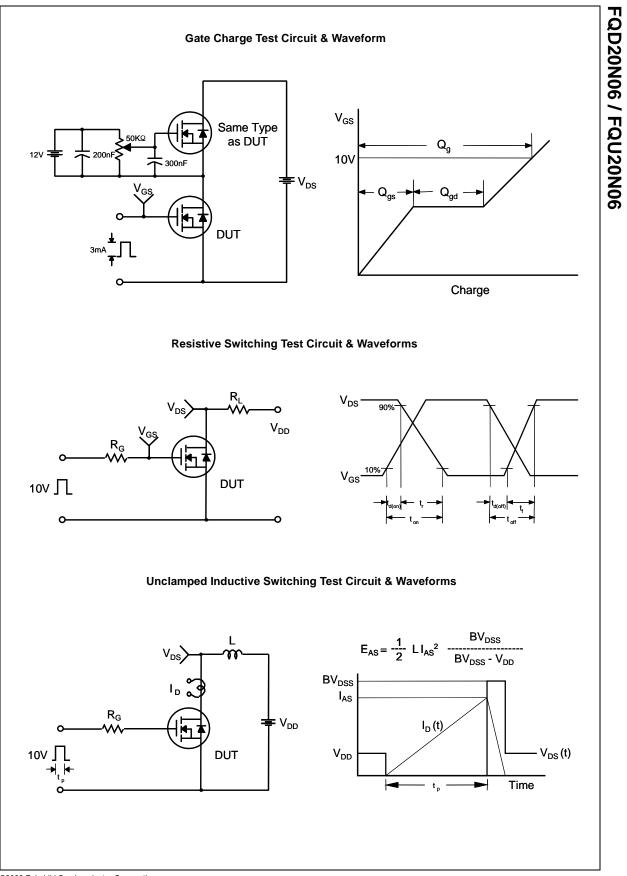
Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		3.28	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		110	°C/W

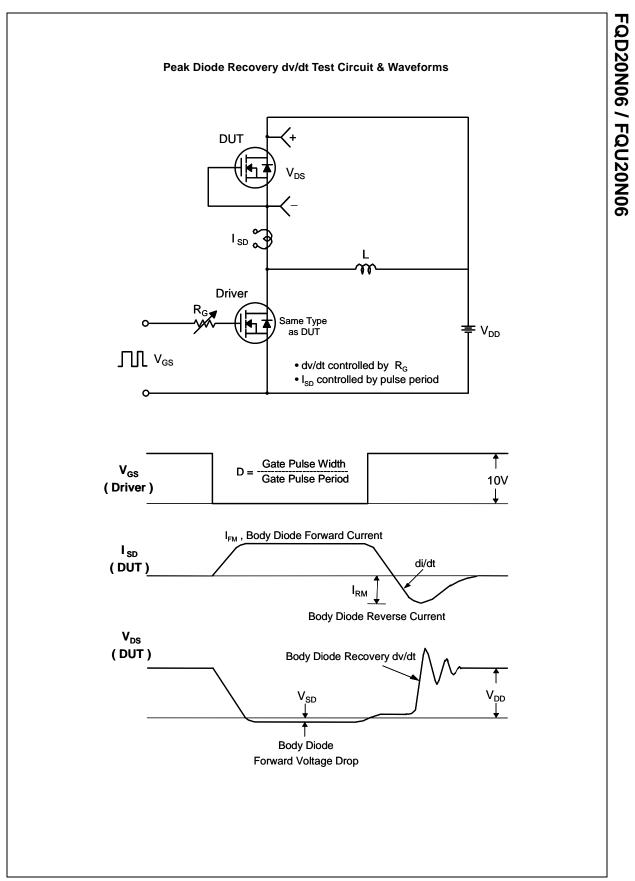
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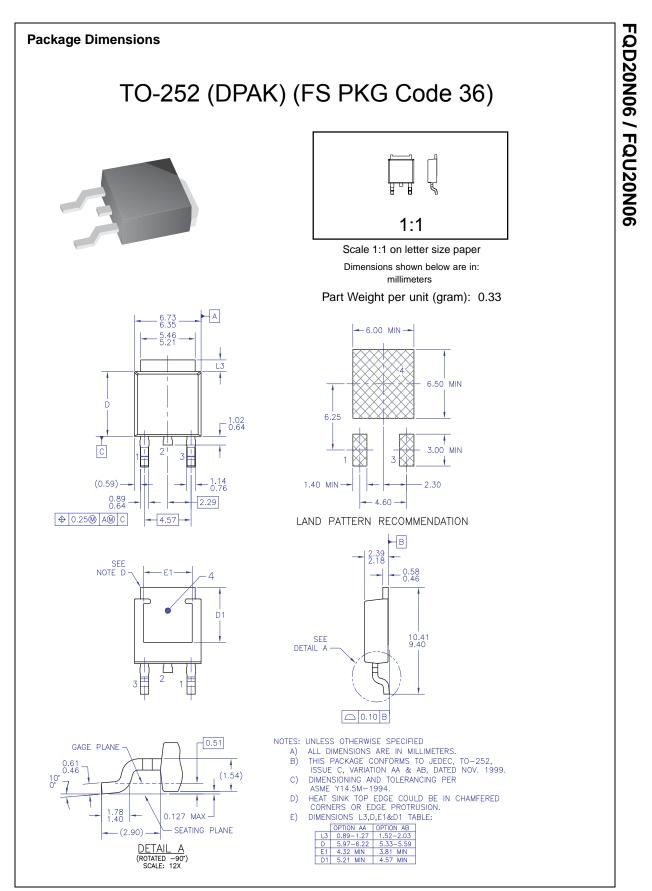
	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	60			V
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to 25°C		0.07		V/°C
IDSS	Zara Cata Valtaga Drain Current	$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$			1	μA
	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 48 V, T <sub>C</sub> = 125°C			10	μA
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	$V_{GS} = 25 V, V_{DS} = 0 V$			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	$V_{GS} = -25 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			-100	nA
On Cha	aracteristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 10 V, I_{D} = 8.4 A$		0.050	0.063	Ω
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 25 \text{ V}, I_D = 8.4 \text{ A}$ (Note 4)		10		S
Dynam	ic Characteristics					
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V,		450	590	pF
C <sub>oss</sub>	Output Capacitance	f = 1.0  MHz		170	220	pF
Crss	Reverse Transfer Capacitance			25	35	pF
d(on) r	Turn-On Delay Time Turn-On Rise Time	$V_{DD} = 30$ V, $I_D = 10$ A, R <sub>G</sub> = 25 Ω		5 45	20 100	ns ns
t <sub>r</sub>		$R_{G} = 25 \Omega$				
	Turn-Off Delay Time	(Note 4, 5)		20 25	50	ns
	Turn Off Fall Time			20	60	ns
f	Turn-Off Fall Time				45	
f Qg	Total Gate Charge	V <sub>DS</sub> = 48 V, I <sub>D</sub> = 20 A,		11.5	15	nC
f Q <sub>g</sub> Q <sub>gs</sub>	Total Gate Charge Gate-Source Charge	V <sub>DS</sub> = 48 V, I <sub>D</sub> = 20 A, V <sub>GS</sub> = 10 V		11.5 3		nC nC
t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total Gate Charge Gate-Source Charge Gate-Drain Charge	$V_{DS}$ = 48 V, I <sub>D</sub> = 20 A, V <sub>GS</sub> = 10 V (Note 4, 5)		11.5		nC
t <sub>f</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub> Drain-S	Total Gate Charge Gate-Source Charge Gate-Drain Charge	$V_{DS} = 48 \text{ V}, I_D = 20 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4, 5)		11.5 3 4.5		nC nC nC
կ Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub> Drain-S	Total Gate Charge Gate-Source Charge Gate-Drain Charge Gource Diode Characteristics an Maximum Continuous Drain-Source Dio	$V_{DS} = 48 \text{ V}, I_D = 20 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4, 5) <b>Ad Maximum Ratings</b> de Forward Current		11.5 3 4.5	  16.8	nC nC nC
t <sub>f</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub> <b>Drain-S</b> Is	Total Gate Charge Gate-Source Charge Gate-Drain Charge <b>Source Diode Characteristics ar</b> Maximum Continuous Drain-Source Diode F Maximum Pulsed Drain-Source Diode F	$V_{DS} = 48 \text{ V}, I_D = 20 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4, 5) <b>nd Maximum Ratings</b> de Forward Current Forward Current		11.5 3 4.5	  16.8 67.2	nC nC nC A A
t <sub>f</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub> Drain-S Is S V <sub>SD</sub>	Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics an Maximum Continuous Drain-Source Diode Maximum Pulsed Drain-Source Diode F Drain-Source Diode Forward Voltage	$V_{DS} = 48 \text{ V}, I_D = 20 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4, 5) <b>nd Maximum Ratings</b> de Forward Current Forward Current $V_{GS} = 0 \text{ V}, I_S = 16.8 \text{ A}$	  	11.5 3 4.5  	  16.8 67.2 1.5	nC nC nC A A V
t <sub>f</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub> <b>Drain-S</b>	Total Gate Charge Gate-Source Charge Gate-Drain Charge <b>Source Diode Characteristics ar</b> Maximum Continuous Drain-Source Diode F Maximum Pulsed Drain-Source Diode F	$V_{DS} = 48 \text{ V}, I_D = 20 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4, 5) <b>nd Maximum Ratings</b> de Forward Current Forward Current		11.5 3 4.5	  16.8 67.2	nC nC nC A A

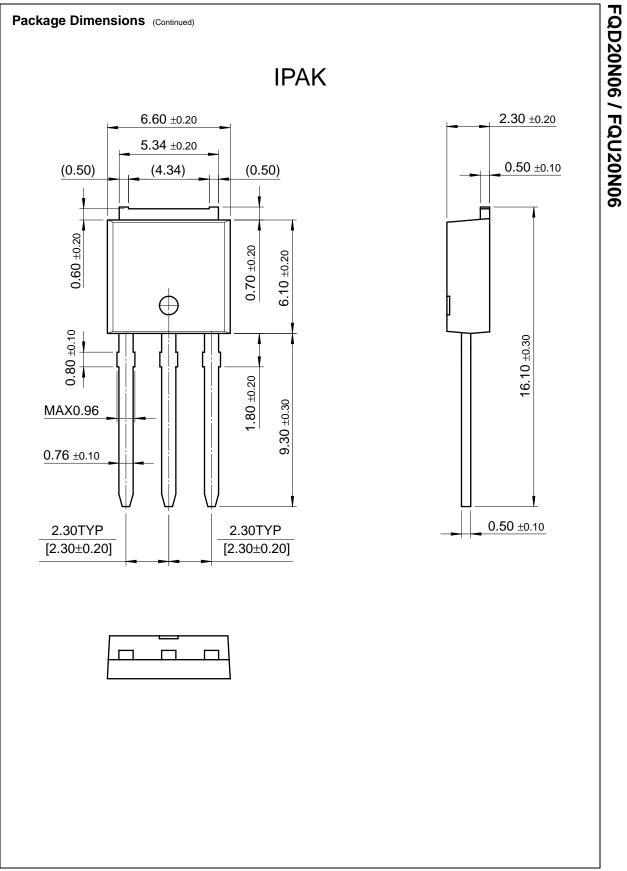














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